

Drell-Yan Differential Cross Section Measurement in Dimuon Channel at 13TeV with the CMS Detector



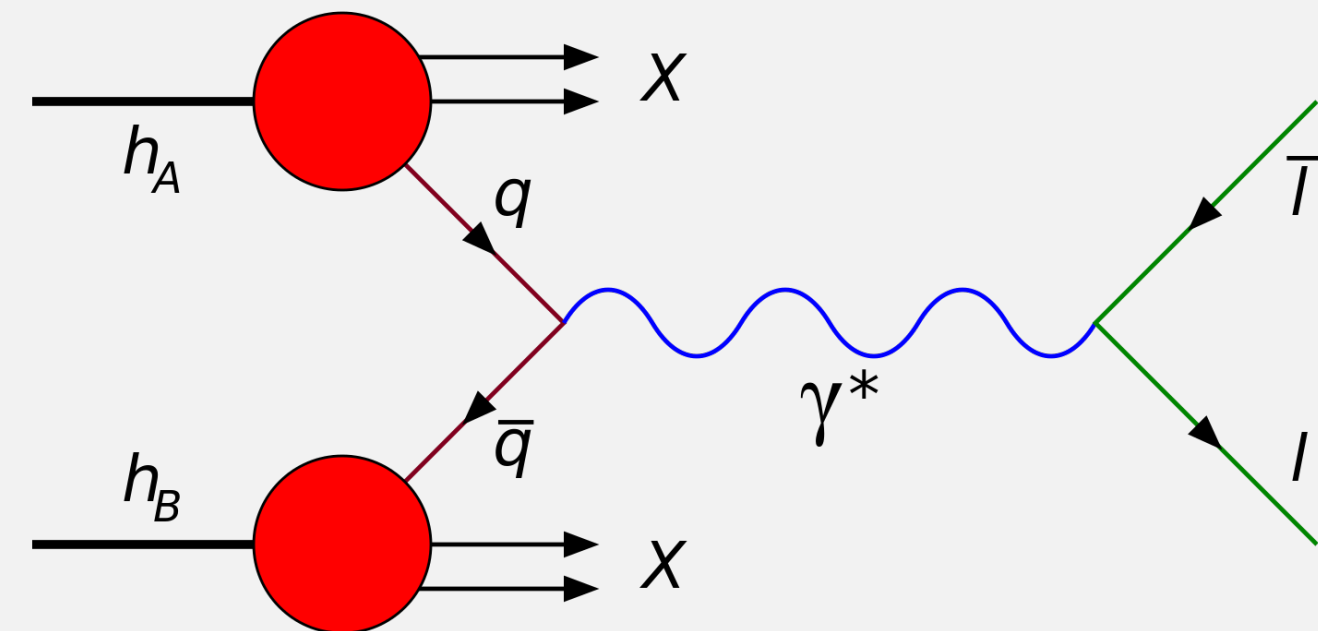
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CMS-PAS-SMP-16-009

Introduction

Drell-Yan process

lepton pairs are produced via γ^*/Z exchange



Motivation

- PDF constraints
- Important as background for BSM

DY differential cross section is continuously measured in CMS

Three papers are already published using 7-8TeV data^[*], and

This is the **first measurement using 13TeV data!**

[*] JHEP10(2011)007, JHEP12(2013)030 and Eur. Phys. J. C (2015) 75:147

Analysis Overview

Goal

Measure the differential cross section $d\sigma/dm$ of Drell-Yan process

- 2.8 fb⁻¹ data
- Dimuon channel
- 15 < M < 3000 GeV, 43 bins

Cross section in i-th mass bin

$$\sigma_i = \frac{N_i^u}{A_i \varepsilon_i L}$$

Labels: A_i (Acceptance), ε_i (Efficiency), L (Integrated Luminosity)

Observed yield with

- momentum scale correction
- background subtraction
- unfolding correction

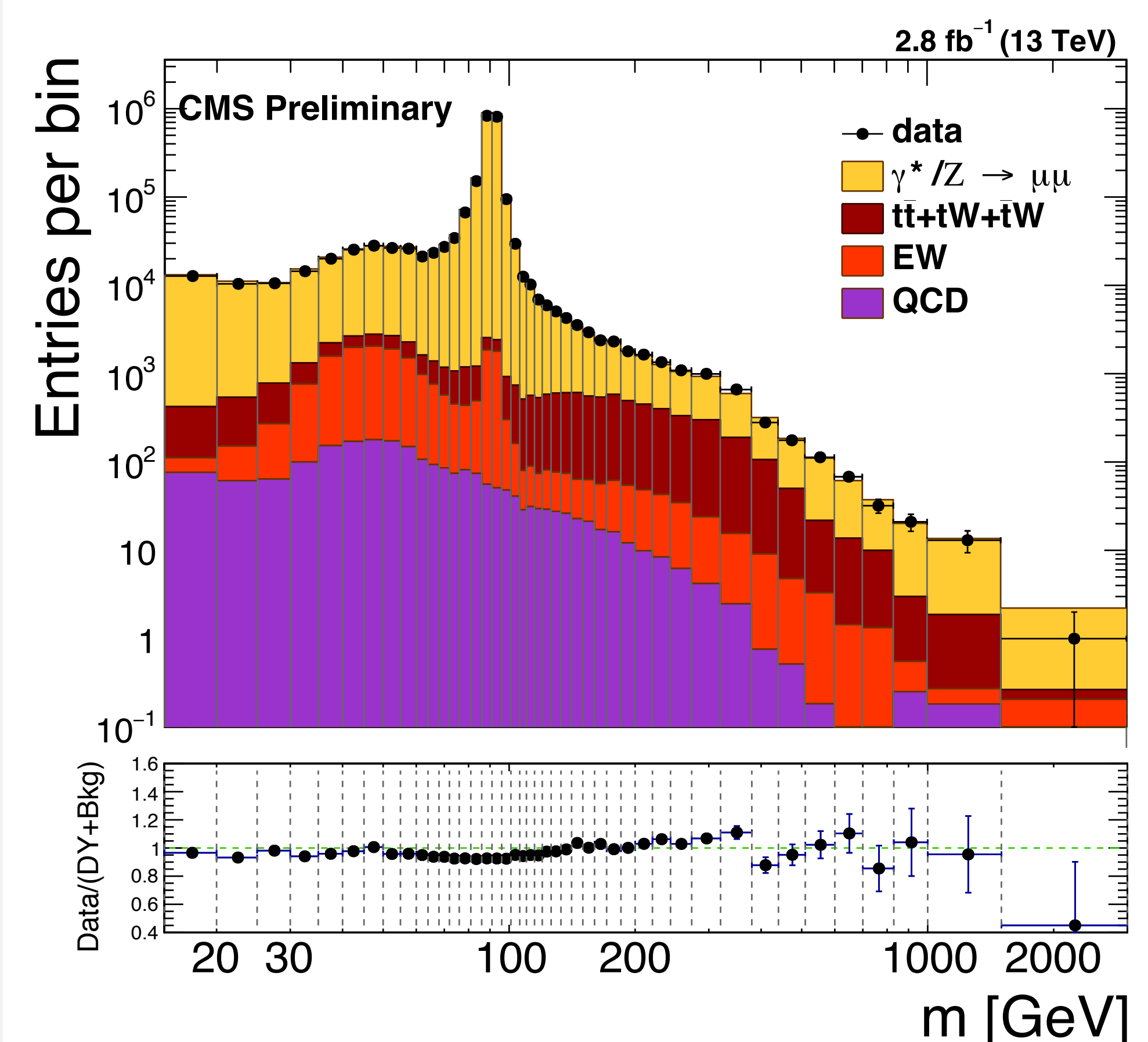
Event Selection & Background Estimation

Event selection

- Isolated single μ trigger ($P_T > 20$ GeV)
- $P_{T\text{-lead}}(\text{sub}) > 22$ (10) GeV, $|\eta| < 2.4$
- CMS standard μ selection

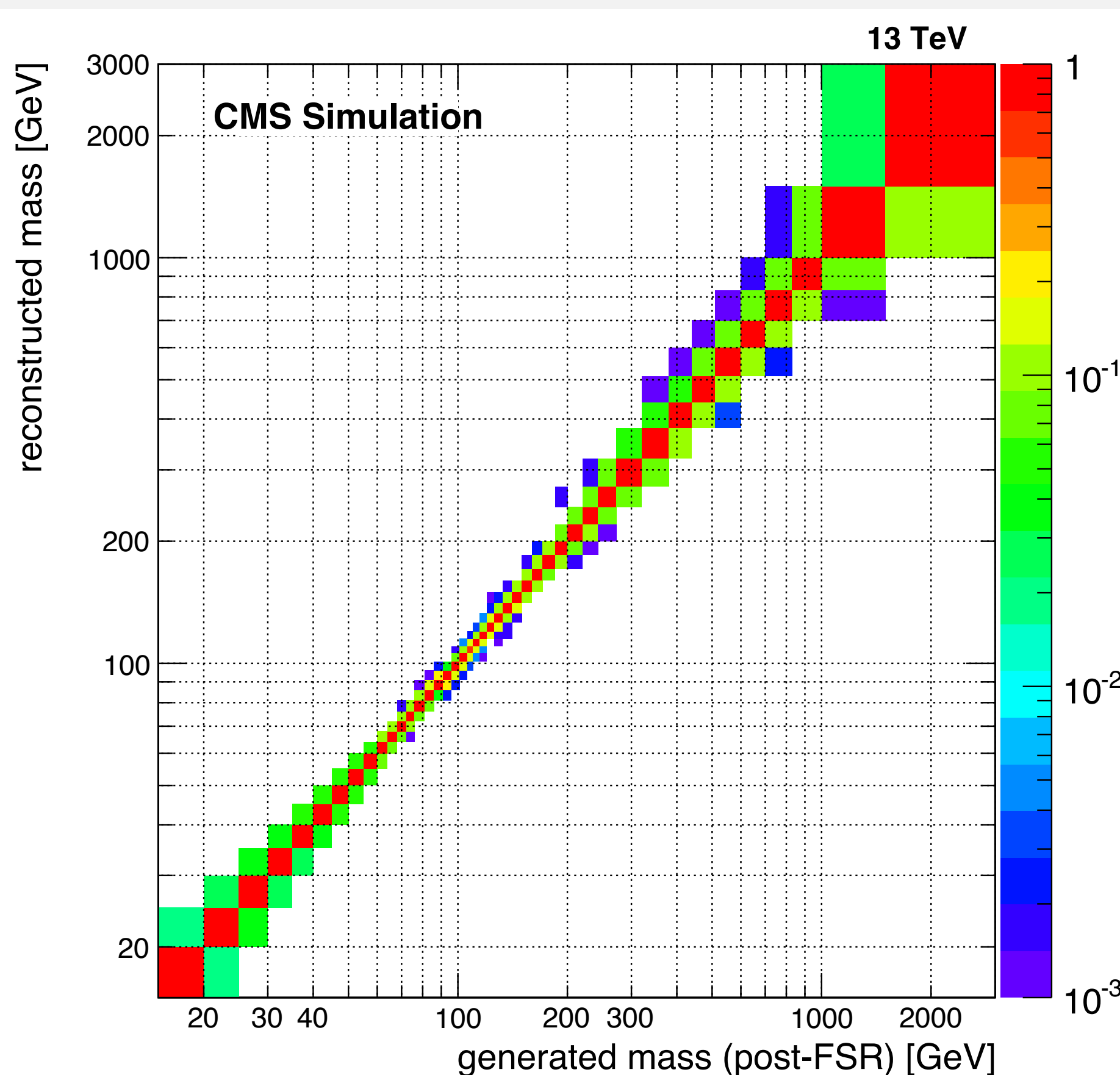
Background estimation

- Data-driven:**
 - Fake rate method: QCD, W+Jets
 - $e\mu$ method: WW, DY $\rightarrow \tau\tau$, $t\bar{t}$, $tW+\bar{t}W$
- MC-based:** WZ, ZZ



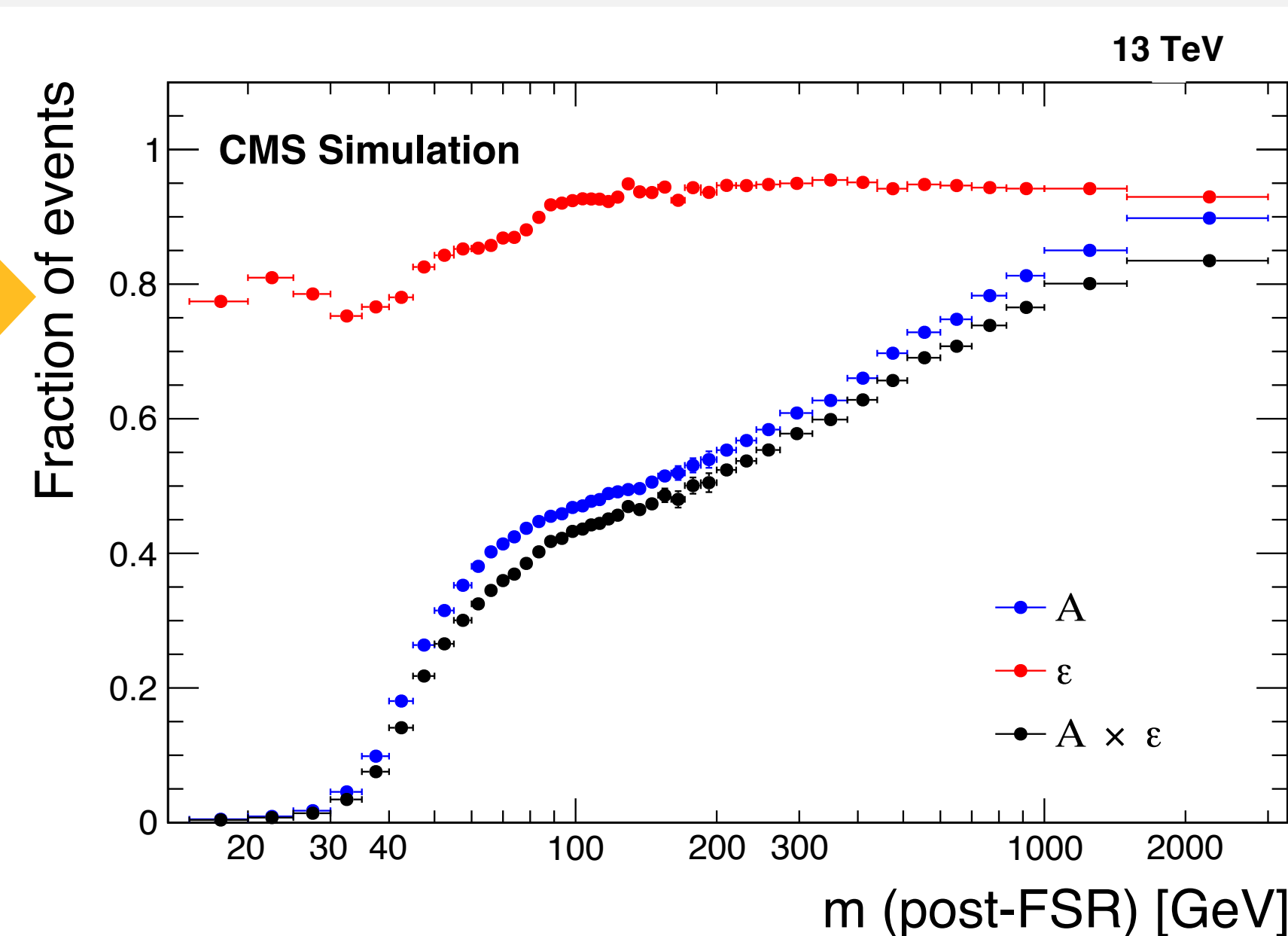
[1] Unfolding for the detector resolution

- Correct the bin migration effect
- Response matrix: from aMC@NLO



[2] Acceptance & Efficiency

$$A \times \varepsilon = \frac{\# \text{ events passing acceptance cut}}{\# \text{ total events}} = \frac{N_{\text{acc}}}{N_{\text{gen}}} \times \frac{\# \text{ events passing event selection}}{\# \text{ events passing acceptance cut}} = \frac{N_{\text{sel}}}{N_{\text{gen}}}$$



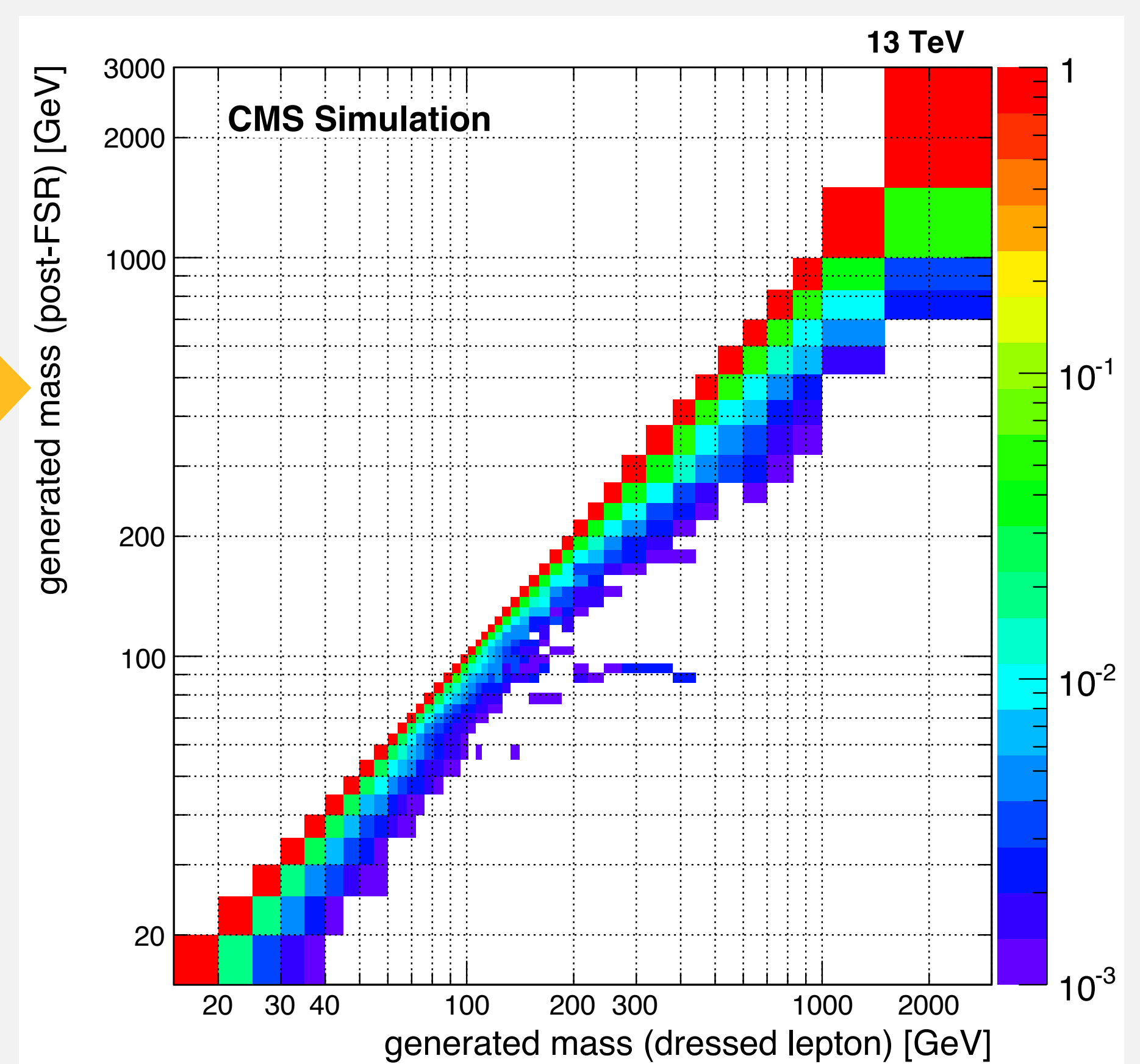
Difference between ε_{MC} and $\varepsilon_{\text{DATA}}$: corrected by scale factor from Tag&Probe method

[3] FSR correction

Corrections

To obtain dressed lepton's distribution

$$\vec{P}_{\text{dressed}}^{\mu} = \vec{P}_{\text{post-FSR}}^{\mu} + \sum_{\Delta R(l, \gamma) < 0.1} \vec{P}^{\gamma}$$

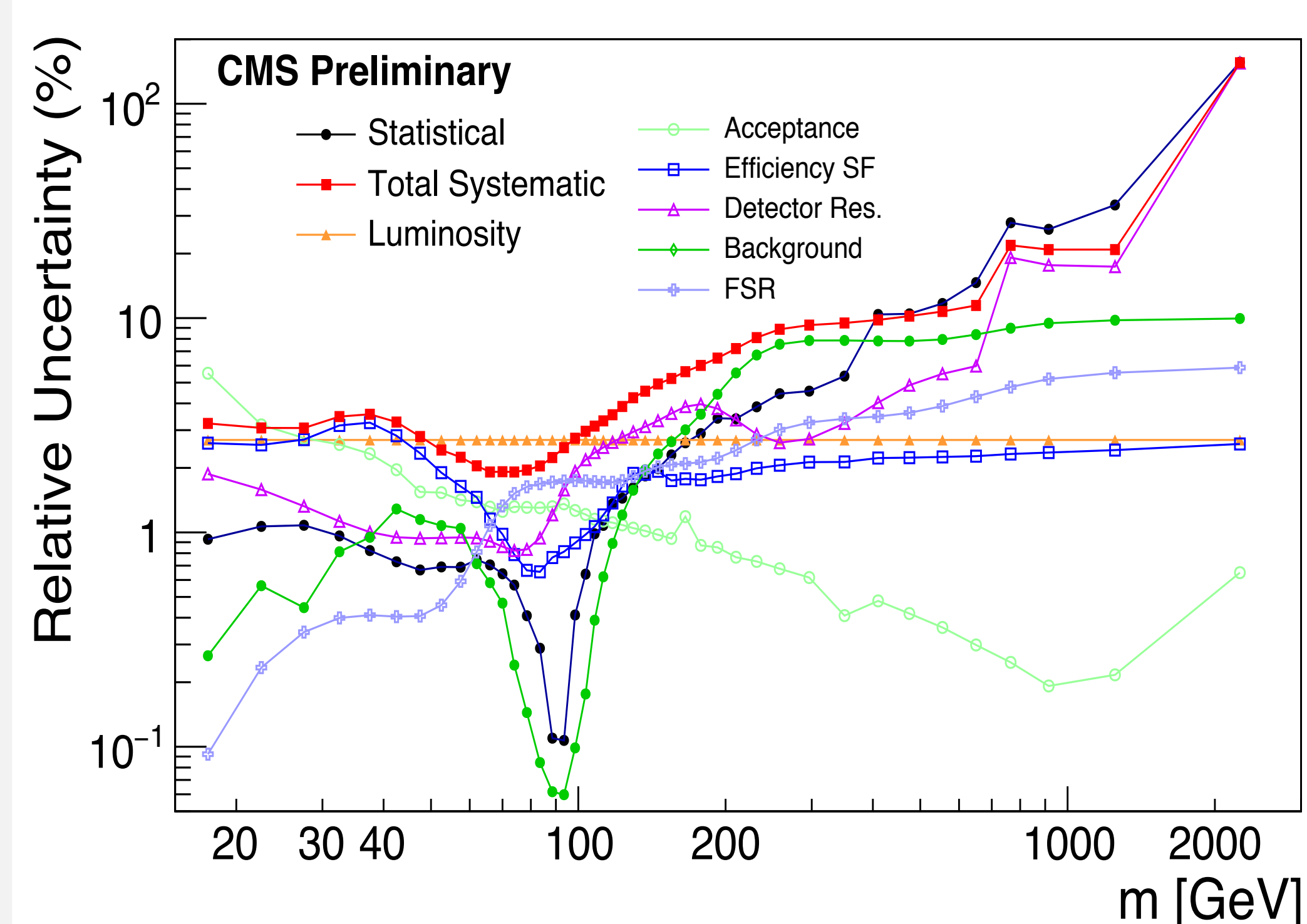


Systematic Uncertainties

Low mass: efficiency scale factor (~3%)

Z peak: FSR (< 2%)

High mass: background (< 10%)

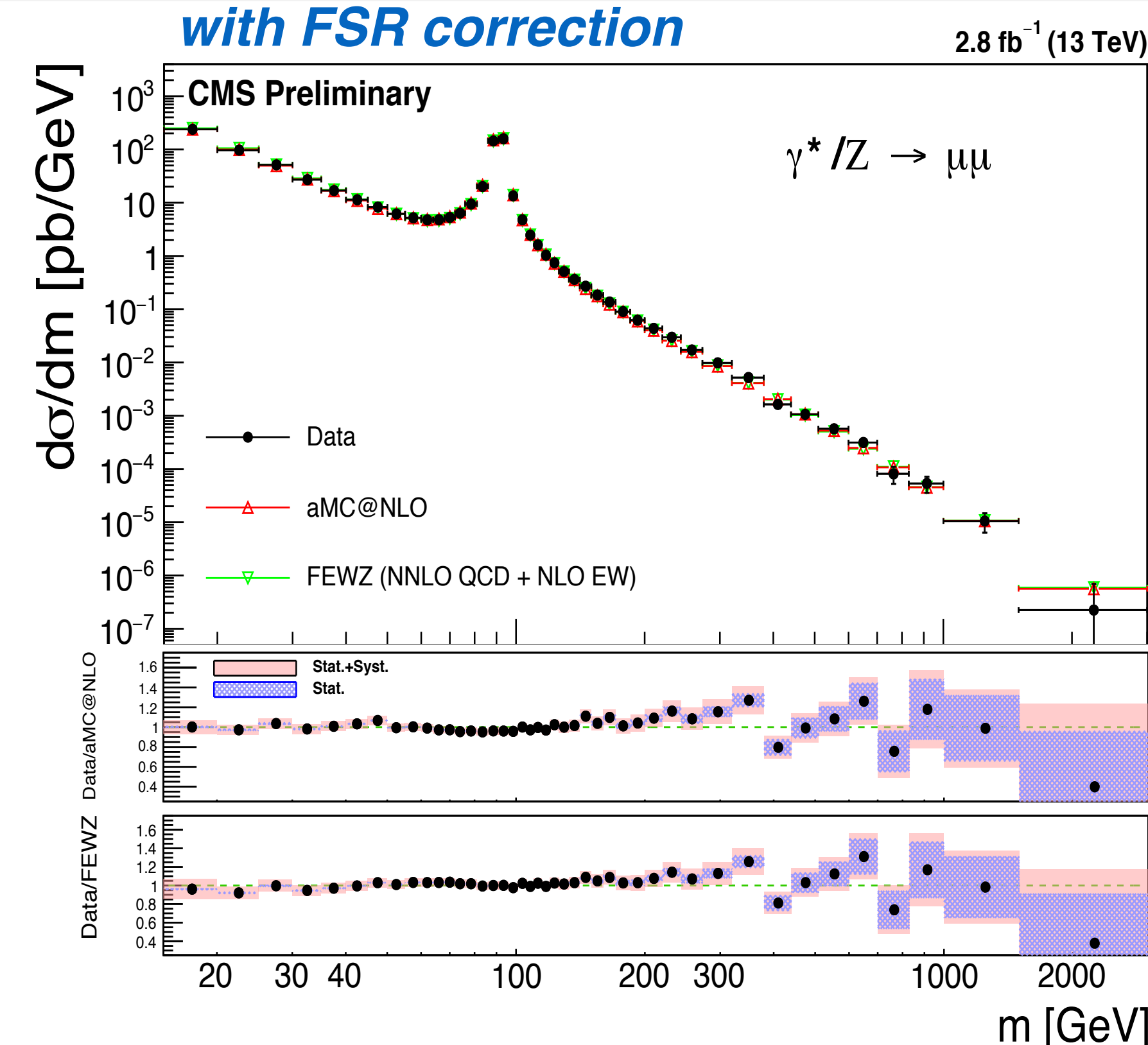


Compared with FEWZ (NNLO, NNPDF3.0) and aMC@NLO

Results & Conclusion

Experimental result generally shows good agreement with the prediction

Full phase space diff. x-section with FSR correction



Fiducial diff. x-section without FSR correction

